Search Notes

Application/Control No.	Applicant(s)/Par Reexamination
10/814.824	CATTANEO ET

2611

10/814,824 Examiner

Emmanuel Bayard

Applicant(s)/Patent under
Reexamination
CATTANEO ET AL.
Art Unit

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Class	Subclass	Date	Examiner
375	354	4/18/2007	EB
375	316	4/18/2007	EB
375	343	4/18/2007	EB
375	340	4/18/2007	EB
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	354	4/18/2007	EB
375	340	4/18/2007	EB

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